

Application/Control	No.
10/595,148	

Examiner Hai H. Huynh Applicant(s)/Patent under Reexamination
NEISE ET AL.

Art Unit 3747

	ORIGI	NAL					, INT	ERNATION	AL CLASSI	FICATION				
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	CROSS REF	ERENCES						,			,			
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(Assistant Examiner) (Date)					Hai Huynh 7/2/				Total Claims Allowed: 16					
	struments Examin	(Primary	(Primary Examiner) (Date)					O.G. Print Claim(s)						

	laims	renur	umbered in the same order as presented by applicant [□СРА			☐ T.D.		☐ R.1.47		
Final) Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
2	2			32			62			92	:		122			152			182
4	თ			33			63			93			123			153			183
6	4			34			64			94			124			154			184
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8	6			36			66			96			126			156			186
9	7			37			67			97			127	!		157			187
10	8			38			68			98			128			158			188
11	9			39			69			99			129			159			189
12	10			40			70			100			130			160			190
13	11			41			71	}		101			131			161			191
14	12			42			72			102			132			162			192
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15	14			44			74	1		104			134			164			194
3	15			45			75	1		105			135			165			195
16	16			46			76	1		106			136			166			196
	17			47			77	1		107			137	ĺ		167			197
	18			48			78	1		108			138			168			198
	19			49			79			109			139			169			199
	20			50			80	1		110			140			170			200
	21			51			81	1		111			141			171			201
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	23			53			83	1		113			143			173			203
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	26			56			86			116			146			176			206
	27			57			87	}		117			147			177			207
	28			58			88]		118			148			178			208
	29			59			89]		119			149			179			209
	30			60			90			120			150			180			210